Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (L^2 - π -MOSV)

2SK2789

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• 4 V gate drive

 $\begin{array}{ll} \bullet & Low\ drain-source\ ON\ resistance & \vdots\ RDS\ (ON) = 66\ m\Omega\ (typ.) \\ \bullet & High\ forward\ transfer\ admittance & \vdots\ |Y_{fs}| = 16\ S\ (typ.) \\ \bullet & Low\ leakage\ current & \vdots\ IDSS = 100\ \mu A\ (max)\ (V_{DS} = 100\ V) \\ \bullet & Enhancement-mode & \vdots\ V_{th} = 0.8 \\ \sim 2.0\ V\ (V_{DS} = 10\ V,\ ID = 1\ mA) \end{array}$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	100	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	100	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	27	Α	
	Pulse (Note 1)	I _{DP}	108	Α	
Drain power dissipatio	n (Tc = 25°C)	P _D	60	W	
Single pulse avalanche energy (Note 2)		E _{AS}	193	mJ	
Avalanche current		I _{AR}	27	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	6	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	2.08	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

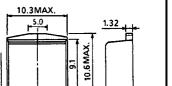
Note 1: Please use devices on condition that the channel temperature is below 150°C.

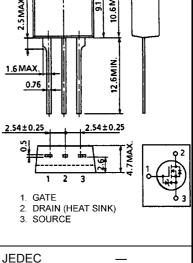
Note 2: V_{DD} = 25 V, T_{ch} = 25 °C (initial), L = 428 μ H, I_{AR} = 27 A, R_G = 25 Ω

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.

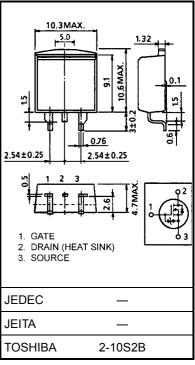




2-10S1B

Weight: 1.5 g (typ.)

JEITA TOSHIBA



Weight: 1.5 g (typ.)

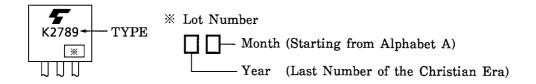
Electrical Characteristics (Ta = 25°C)

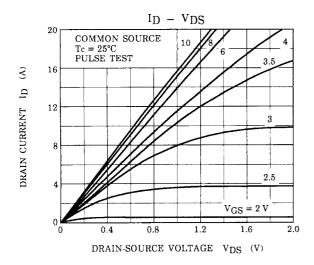
Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μΑ	
Drain cut-off cur	rent	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	_	_	100	μΑ	
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	100	_	_	V	
Gate threshold v	roltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V	
Drain-source ON resistance		R _{DS (ON)}	V _{DS} = 4 V, I _D = 15 A		0.09	0.13	Ω	
			V _{DS} = 10 V, I _D = 15 A	1	0.066	0.085		
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 15 A	8	16	_	S	
Input capacitanc	е	C _{iss}		_	1100	_		
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	-	180	_	pF	
Output capacitar	nce	Coss		-	400	_		
Switching time	Rise time	t _r	V _{GS} _{0V} I _D =15A V _{CS} _{0V} CUT R _L =3.3Ω	_	20	_	- ns	
	Turn-on time	t _{on}		_	30	_		
	Fall time	t _f		_	50	_		
	Turn-off time	t _{off}	$V_{DD} = 50V$ Duty $\leq 1\%$, $t_{\mathbf{W}} = 10 \mu s$	4.40	_			
Total gate charge (gate-source plus gate-drain)		Qg		_	50	_		
Gate-source charge		Q _{gs}	$V_{DD} \approx 80 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 27 \text{ V}$		34	_	nC	
Gate-drain ("miller") Charge		Q _{gd}			16	_		

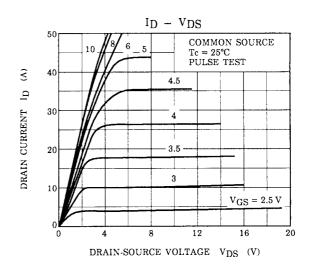
Source-Drain Ratings and Characteristics (Ta = 25°C)

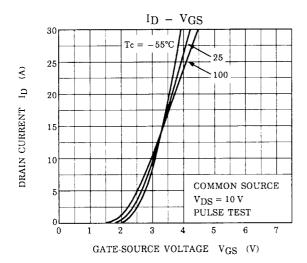
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	27	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	108	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 27 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 27 A, V _{GS} = 0 V, dI _{DR} / dt = 50 A / μs	1	155		ns
Reverse recovery charge	Q_{rr}	1DR - 27 Λ, VGS - 0 V, UDR 7 Ut - 30 Α 7 μs	_	0.31	_	μC

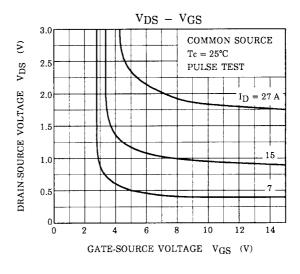
Marking

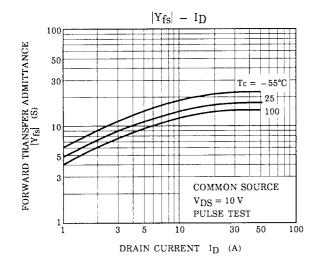


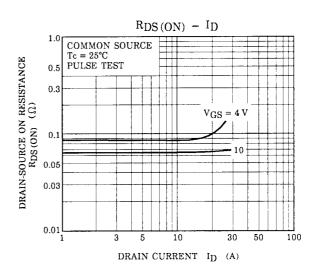




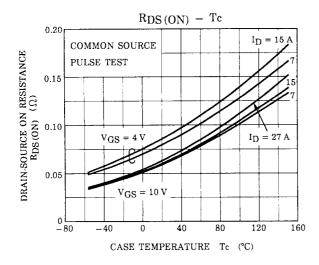


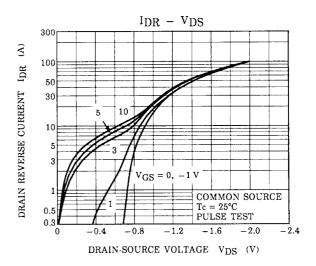


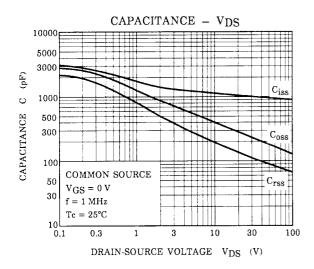


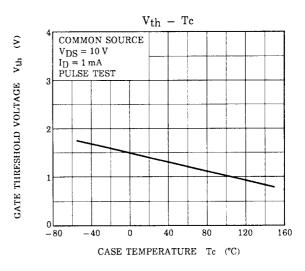


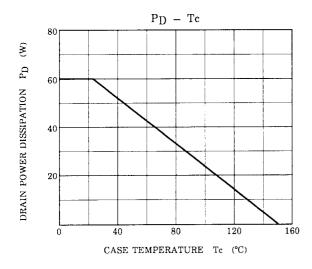
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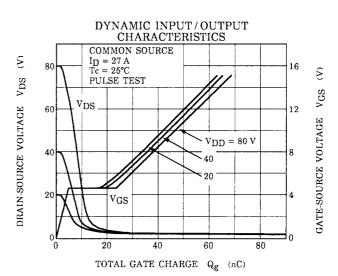




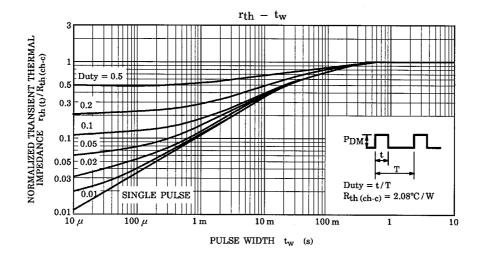


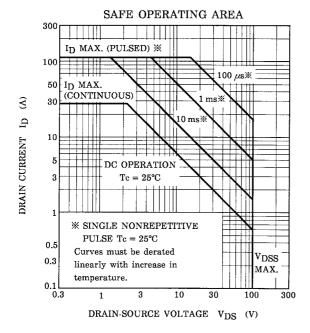


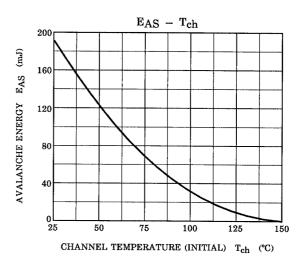


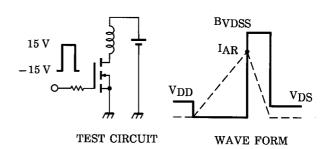


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$$R_G = 25 \Omega$$

 $V_{DD} = 25 V$, $L = 428 \mu H$

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$$E_{AS} = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

2002-06-27

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